

SKM 300 GARL 066 T



SEMITRANS[®] 5

Trench IGBT Modules

SKM 300 GARL 066 T

Target Data

Features

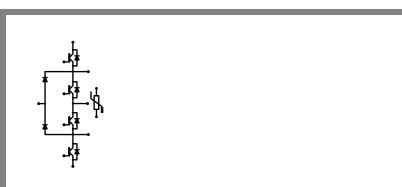
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Integrated NTC temperature sensor

Typical Applications

- UPS
- 3 Level Inverter

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max, recommended $T_{op} = -40..+150^\circ\text{C}$



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Absolute Maximum Ratings		$T_{case} = 25^\circ\text{C}$, unless otherwise specified			
Symbol	Conditions	Values		Units	
IGBT					
V_{CES}	$T_j = 25^\circ\text{C}$	600		V	
I_C	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	400		A
		$T_c = 80^\circ\text{C}$	300		A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	600		A	
V_{GES}		± 20		V	
t_{psc}	$V_{CC} = 360\text{ V}; V_{GE} \leq 15\text{ V}; T_j = 150^\circ\text{C}$ $V_{CES} < 600\text{ V}$	6		μs	
Inverse Diode					
I_F	$T_j = 150^\circ\text{C}$	$T_c = 25^\circ\text{C}$	40		A
		$T_c = 80^\circ\text{C}$	30		A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	60		A	
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave}$ $T_j = 150^\circ\text{C}$	160		A	
Freewheeling Diode					
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	400		A
		$T_c = 80^\circ\text{C}$	290		A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	600		A	
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave}$ $T_j = 150^\circ\text{C}$	2100		A	
Module					
$I_{l(RMS)}$		500		A	
T_{vj}		- 40 ... + 175		$^\circ\text{C}$	
T_{stg}		- 40 ... + 125		$^\circ\text{C}$	
V_{isol}	AC, 1 min.	2500		V	

Characteristics		$T_{case} = 25^\circ\text{C}$, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 4,8\text{ mA}$	5	5,8	6,5	V
I_{CES}	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}$ $T_j = 25^\circ\text{C}$			0,015	mA
I_{GES}	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V}$ $T_j = 25^\circ\text{C}$			1200	nA
V_{CE0}		$T_j = 25^\circ\text{C}$	0,9		V
		$T_j = 150^\circ\text{C}$	0,85		V
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$	1,8		$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	2,7		$\text{m}\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 300\text{ A}, V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$	1,45		V
		$T_j = 150^\circ\text{C}_{chiplev.}$	1,7		V
C_{ies}	$V_{CE} = 25, V_{GE} = 0\text{ V}$ $f = 1\text{ MHz}$			18,4	nF
C_{oes}				1,14	nF
C_{res}				0,54	nF
R_{Gint}	$T_j = ^\circ\text{C}$			1	Ω
$t_{d(on)}$	$R_{Gon} = 1\ \Omega$	$V_{CC} = 300\text{ V}$ $I_C = 300\text{ A}$			ns
t_r					ns
E_{on}	$R_{Goff} = 2\ \Omega$	$T_j = 150^\circ\text{C}$ $V_{GE} = -8\text{ V}/+15\text{ V}$	1,56		mJ
$t_{d(off)}$					ns
t_f					ns
E_{off}			9,4		mJ
$R_{th(j-c)}$	per IGBT			0,15	K/W

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Typical Applications

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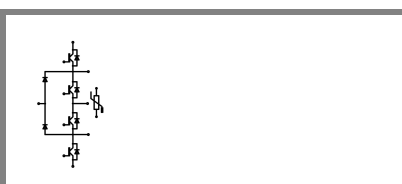
Remarks

- Case temperature limited to $T_C = 125^\circ\text{C}$ max, recommended $T_{op} = -40..+150^\circ\text{C}$

Characteristics					
Symbol	Conditions	min.	typ.	max.	Units
Inverse Diode					
$V_F = V_{EC}$	$I_{Fnom} = 30 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$	1,45	1,7	V
		$T_j = 125^\circ\text{C}_{chiplev.}$	1,45	1,7	V
V_{F0}		$T_j = 25^\circ\text{C}$	1	1,1	V
		$T_j = 125^\circ\text{C}$	0,9	1	V
r_F		$T_j = 25^\circ\text{C}$	15	20	m Ω
		$T_j = 125^\circ\text{C}$	18	23,3	m Ω
I_{RRM}	$I_F = 30 \text{ A}$	$T_j = 125^\circ\text{C}$			A
Q_{rr}					μC
E_{tr}	$V_{GE} = -8 \text{ V}; V_{CC} = 300 \text{ V}$				mJ
$R_{th(j-c)D}$	per diode		2		K/W
Free-wheeling diode					
$V_F = V_{EC}$	$I_{Fnom} = 300 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$	1,35	1,6	V
		$T_j = 125^\circ\text{C}_{chiplev.}$	1,3	1,5	V
V_{F0}		$T_j = 25^\circ\text{C}$	0,9	1	V
		$T_j = 125^\circ\text{C}$	0,85	0,9	V
r_F		$T_j = 25^\circ\text{C}$	1,5	2	V
		$T_j = 125^\circ\text{C}$	1,5	2	V
I_{RRM}	$I_F = 300 \text{ A}$	$T_j = 125^\circ\text{C}$			A
Q_{rr}					μC
E_{tr}	$V_{GE} = 0 \text{ V}; V_{CC} = 600 \text{ V}$		5		mJ
$R_{th(j-c)FD}$	per diode		0,26		K/W
M_s	to heat sink M6	3		5	Nm
M_t	to terminals M6	2,5		5	Nm
w				310	g
Temperature sensor					
R_{100}	$T_s = 100^\circ\text{C} (R_{25} = 5\text{k}\Omega)$		493 \pm 5%		Ω K

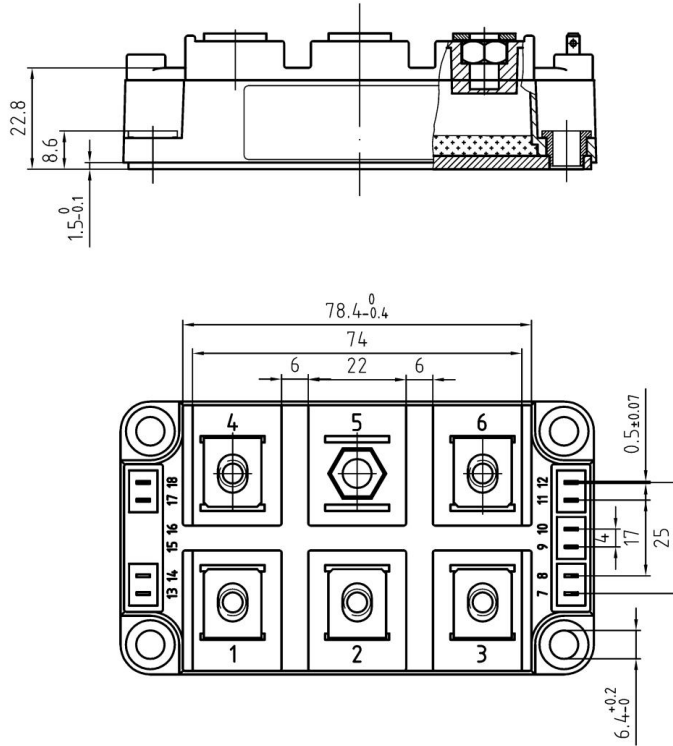
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.

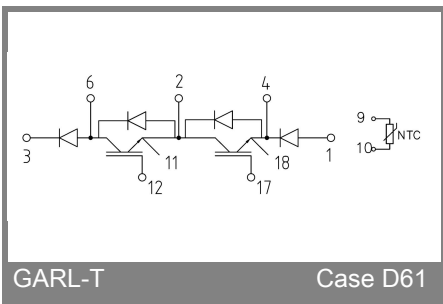


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Case D61



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